## Applicant(s)/Patent Under Application/Control No. Reexamination 10/048,058 YAMANASHI, FUMINORI Notice of References Cited Art Unit Examiner Page 1 of 1 1745 Dah-Wei D. Yuan **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,638,652 B1 10-2003 Motozono et al. 429/19 В US-6,676,907 B1 01-2004 422/193 Benz et al. С US-US-D US-Ε F US-US-G Н US-US-1 J US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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